Biostat 602 Winter 2017

Lecture Set 17

Hypothesis Testing Likelihood Ratio Test

Reading: CB 8.2

# Likelihood Ratio Tests (LRT)

**Definition** Let  $L(\theta|\mathbf{x})$  be the likelihood function of  $\theta$ . The likelihood ratio test statistic for testing  $H_0: \theta \in \Omega_0$  vs.  $H_1: \theta \in \Omega_0^c$  is

$$\lambda(\mathbf{x}) = \frac{\sup_{\theta \in \Omega_0} L(\theta|\mathbf{x})}{\sup_{\theta \in \Omega} L(\theta|\mathbf{x})} = \frac{L(\hat{\theta}_0|\mathbf{x})}{L(\hat{\theta}|\mathbf{x})}$$

where  $\hat{\theta}$  is the MLE of  $\theta$  over  $\theta \in \Omega$ , and  $\hat{\theta}_0$  is the MLE of  $\theta$  over  $\theta \in \Omega_0$  (restricted MLE).

The *likelihood ratio test* is a test that rejects  $H_0$  if and only if  $\lambda(\mathbf{x}) \leq c$  where  $0 \leq c \leq 1$ .

c is obtained from the size condition of the test, namely

$$\sup_{\theta \in \Omega_0} \beta(\theta) = \alpha$$

where  $\beta(\theta) = \Pr(\mathbf{X} \in R | \theta) = \Pr(\text{reject } H_0 | \theta)$  is the power function of the test.

# LRT based on sufficient statistics

**Theorem 8.2.4:** If  $T(\mathbf{X})$  is a sufficient statistic for  $\theta$ ,  $\lambda^*(t)$  is the LRT statistic based on T, and  $\lambda(\mathbf{x})$  is the LRT statistic based on  $\mathbf{x}$  then

$$\lambda^*[T(\mathbf{x})] = \lambda(\mathbf{x})$$

for every  $\mathbf{x}$  in the sample space.

**Proof:** By Factorization Theorem, the joint pdf of  $\mathbf{x}$  can be written as

$$f(\mathbf{x}|\theta) = g(T(\mathbf{x})|\theta)h(\mathbf{x})$$

and we can choose  $g(t|\theta)$  to be the pdf or pmf of  $T(\mathbf{x})$ . Then, the LRT statistic based on  $T(\mathbf{X})$  is defined as

$$\lambda^*(t) = \frac{\sup_{\theta \in \Omega_0} L(\theta | T(\mathbf{x}) = t)}{\sup_{\theta \in \Omega} L(\theta | T(\mathbf{x}) = t)} = \frac{\sup_{\theta \in \Omega_0} g(t | \theta)}{\sup_{\theta \in \Omega} g(t | \theta)}$$

LRT statistic based on X is

$$\lambda(\mathbf{x}) = \frac{\sup_{\theta \in \Omega_0} L(\theta|\mathbf{x})}{\sup_{\theta \in \Omega} L(\theta|\mathbf{x})}$$

$$= \frac{\sup_{\theta \in \Omega_0} f(\mathbf{x}|\theta)}{\sup_{\theta \in \Omega} f(\mathbf{x}|\theta)}$$

$$= \frac{\sup_{\theta \in \Omega_0} g(T(\mathbf{x})|\theta)h(\mathbf{x})}{\sup_{\theta \in \Omega} g(T(\mathbf{x})|\theta)h(\mathbf{x})}$$

$$= \frac{\sup_{\theta \in \Omega_0} g(T(\mathbf{x})|\theta)}{\sup_{\theta \in \Omega} g(T(\mathbf{x})|\theta)} = \lambda^*(T(\mathbf{x}))$$

The simplified expression of  $\lambda(\mathbf{x})$  should depend on  $\mathbf{x}$  only through  $T(\mathbf{x})$ , where  $T(\mathbf{x})$  is a sufficient statistic for  $\theta$ .

**Example 1:** Consider  $X_1, \dots, X_n$  i.i.d.  $\mathcal{N}(\theta, \sigma^2)$  where  $\sigma^2$  is known.

$$H_0$$
:  $\theta = \theta_0$   
 $H_1$ :  $\theta \neq \theta_0$ 

Find a size  $\alpha$  LRT.

Solution - Using sufficient statistics: Note that in this case,  $T(\mathbf{X}) = \overline{X}$  is a sufficient statistic for  $\theta$ .

$$T \sim \mathcal{N}\left(\theta, \frac{\sigma^2}{n}\right)$$

$$\lambda(t) = \frac{\sup_{\theta \in \Omega_0} L(\theta|t)}{\sup_{\theta \in \Omega} L(\theta|t)} = \frac{\sqrt{\frac{1}{2\pi\sigma^2/n}} \exp\left[-\frac{(t-\theta_0)^2}{2\sigma^2/n}\right]}{\sup_{\theta \in \Omega} \sqrt{\frac{1}{2\pi\sigma^2/n}} \exp\left[-\frac{(t-\theta)^2}{2\sigma^2/n}\right]}$$

The numerator is fixed, and MLE in the denominator is  $\hat{\theta} = t$ . Therefore the LRT statistic is

$$\lambda(t) = \exp\left[-\frac{n(t-\theta_0)^2}{2\sigma^2}\right]$$

LRT rejects  $H_0$  if and only if

$$\lambda(t) = \exp\left[-\frac{n(t - \theta_0)^2}{2\sigma^2}\right] \le c$$

$$\implies \left|\frac{t - \theta_0}{\sigma/\sqrt{n}}\right| \ge \sqrt{-2\log c} = c^*$$

Note that

$$T = \overline{X} \sim \mathcal{N}\left(\theta, \frac{\sigma^2}{n}\right)$$

$$\frac{T - \theta_0}{\sigma/\sqrt{n}} \sim \mathcal{N}(0, 1)$$

A size  $\alpha$  test satisfies

$$\sup_{\theta \in \Omega_0} \Pr\left( \left| \frac{T - \theta}{\sigma / \sqrt{n}} \right| \ge c^* \right) = \alpha$$

$$\Pr\left( \left| \frac{T - \theta_0}{\sigma / \sqrt{n}} \right| \ge c^* \right) = \alpha$$

$$\Pr\left( |Z| \ge c^* \right) = \alpha$$

$$\Pr(Z \ge c^*) + \Pr(Z \le -c^*) = \alpha$$

$$|Z| = \left| \frac{T - \theta}{\sigma / \sqrt{n}} \right| \ge z_{\alpha/2}$$

# LRT with nuisance parameters

**Example 2:** Let  $X_1, \dots, X_n$  be i.i.d  $\mathcal{N}(\theta, \sigma^2)$  where both  $\theta$  and  $\sigma^2$  are unknown. Obtain a LRT for testing  $H_0: \theta \leq \theta_0$  against  $H_1: \theta > \theta_0$ .

- 1. Specify  $\Omega$  and  $\Omega_0$
- 2. Find size  $\alpha$  LRT.

Solution -  $\Omega$  and  $\Omega_0$ 

$$\Omega = \{(\theta, \sigma^2) : \theta \in \mathbb{R}, \sigma^2 > 0\}$$

$$\Omega_0 = \{(\theta, \sigma^2) : \theta \le \theta_0, \sigma^2 > 0\}$$

Size  $\alpha$  LRT

$$\lambda(\mathbf{x}) = \frac{\sup_{\{(\theta,\sigma^2):\theta \leq \theta_0,\sigma^2 > 0\}} L(\theta,\sigma^2|\mathbf{x})}{\sup_{\{(\theta,\sigma^2):\theta \in \mathbb{R},\sigma^2 > 0\}} L(\theta,\sigma^2|\mathbf{x})}$$

For the denominator, the MLE of  $\theta$  and  $\sigma^2$  are

$$\begin{cases} \hat{\theta} = \overline{X} \\ \hat{\sigma}^2 = \frac{\sum (X_i - \overline{X})^2}{n} = \frac{n-1}{n} s_{\mathbf{X}}^2 \end{cases}$$

For numerator, we need to maximize  $L(\theta, \sigma^2 | \mathbf{x})$  over the region  $\theta \leq \theta_0$  and  $\sigma^2 > 0$ .

$$L(\theta, \sigma^2 | \mathbf{x}) = \left(\frac{1}{\sqrt{2\pi\sigma^2}}\right)^n \exp\left[-\frac{\sum_{i=1}^n (x_i - \theta)^2}{2\sigma^2}\right]$$

### **Maximizing Numerator**

**Step 1:** fix  $\sigma^2$ , likelihood is maximized when  $\sum_{i=1}^n (x_i - \theta)^2$  is minimized over  $\theta \leq \theta_0$ .

$$\hat{\theta}_0 = \begin{cases} \overline{x} & \text{if } \overline{x} \leq \theta_0 \\ \theta_0 & \text{if } \overline{x} > \theta_0 \end{cases}$$

Step 2: Now, we need to maximize likelihood (or log-likelihood) with respect to  $\sigma^2$  and we substitute  $\hat{\theta}_0$  for  $\theta$ .

$$l(\hat{\theta}, \sigma^2 | \mathbf{x}) = -\frac{n}{2} \left( \log 2\pi + \log \sigma^2 \right) - \frac{\sum (x_i - \hat{\theta}_0)^2}{2\sigma^2}$$
$$\frac{\partial \log l}{\partial \sigma^2} = -\frac{n}{2\sigma^2} + \frac{\sum (x_i - \hat{\theta}_0)^2}{2(\sigma^2)^2} = 0$$
$$\hat{\sigma}_0^2 = \frac{\sum_{i=1}^n (x_i - \hat{\theta}_0)^2}{n}$$

Combining the results together

$$\lambda(\mathbf{x}) = \begin{cases} 1 & \text{if } \overline{x} \le \theta_0 \\ \left(\frac{\hat{\sigma}^2}{\hat{\sigma}_0^2}\right)^{n/2} & \text{if } \overline{x} > \theta_0 \end{cases}$$

## Constructing LRT

LRT test rejects  $H_0$  if and only if  $\overline{x} > \theta_0$  and

$$\left(\frac{\hat{\sigma}^2}{\hat{\sigma}_0^2}\right)^{n/2} \leq c$$

$$\left(\frac{\sum (x_i - \overline{x})^2/n}{\sum (x_i - \theta_0)^2/n}\right)^{n/2} \leq c$$

$$\frac{\sum (x_i - \overline{x})^2}{\sum (x_i - \theta_0)^2} \leq c^*$$

$$\frac{\sum (x_i - \overline{x})^2}{\sum (x_i - \overline{x})^2 + n(\overline{x} - \theta_0)^2} \leq c^*$$

$$\frac{1}{1 + \frac{n(\overline{x} - \theta_0)^2}{\sum (x_i - \overline{x})^2}} \leq c^*$$

$$\frac{n(\overline{x} - \theta_0)^2}{\sum (x_i - \overline{x})^2} \ge c^{**}$$

$$\frac{\overline{x} - \theta_0}{s_{\mathbf{X}}/\sqrt{n}} \ge c^{***}$$

LRT test rejects  $H_0$  if

$$\frac{\overline{x} - \theta_0}{s_{\mathbf{X}}/\sqrt{n}} \ge c^{***}$$

The next step is to specify  $c^{***}$  to get size  $\alpha$  test (can you figure out?).

### **Unbiased Test**

**Definition:** If a test always satisfies

 $\Pr(\text{reject } H_0 \text{ when } H_0 \text{ is false }) \geq \Pr(\text{reject } H_0 \text{ when } H_0 \text{ is true })$ 

Then the test is said to be unbiased.

Alternative Definition: Recall that  $\beta(\theta) = \Pr(\text{reject } H_0)$ . A test is unbiased if

$$\beta(\theta') \ge \beta(\theta)$$

for every  $\theta' \in \Omega_0^c$  and  $\theta \in \Omega_0$ .

**Example 3:** Let  $X_1, \dots, X_n$  be i.i.d.  $\mathcal{N}(\theta, \sigma^2)$  where  $\sigma^2$  is known, testing  $H_0: \theta \leq \theta_0$  vs  $H_1: \theta > \theta_0$ . LRT test rejects  $H_0$  if

$$\frac{\overline{x} - \theta_0}{\sigma / \sqrt{n}} > c.$$

$$\beta(\theta) = \Pr\left(\frac{\overline{X} - \theta_0}{\sigma/\sqrt{n}} > c\right)$$

$$= \Pr\left(\frac{\overline{X} - \theta + \theta - \theta_0}{\sigma/\sqrt{n}} > c\right)$$

$$= \Pr\left(\frac{\overline{X} - \theta}{\sigma/\sqrt{n}} + \frac{\theta - \theta_0}{\sigma/\sqrt{n}} > c\right)$$

$$= \Pr\left(\frac{\overline{X} - \theta}{\sigma/\sqrt{n}} > c + \frac{\theta_0 - \theta}{\sigma/\sqrt{n}}\right)$$

Note that  $X_i \sim \mathcal{N}(\theta, \sigma^2)$ ,  $\overline{X} \sim \mathcal{N}(\theta, \sigma^2/n)$ , and  $\frac{\overline{X} - \theta}{\sigma/\sqrt{n}} \sim \mathcal{N}(0, 1)$ . Therefore, for  $Z \sim \mathcal{N}(0, 1)$ 

$$\beta(\theta) = \Pr\left(Z > c + \frac{\theta_0 - \theta}{\sigma/\sqrt{n}}\right)$$

Because the power function is increasing function in  $\theta$ ,

$$\beta(\theta') \ge \beta(\theta)$$

always holds when  $\theta \leq \theta_0 < \theta'$ . Therefore the LRTs are unbiased.

Question: Can the same test be biased when hypotheses change?

Example 4: Same framework as before.

- New hypotheses:  $H_0: \theta = \theta_0, H_1: \theta \neq \theta_0.$
- Same test :  $R = \left\{ \frac{\overline{x} \theta_0}{\sigma / \sqrt{n}} > c \right\}$ .

## Testing unbiasedness

The power function  $\beta(\theta)$  is still an increasing function. Therefore, if  $\theta_+ > \theta_0 > \theta_-$ , then

$$\beta(\theta_{+}) > \beta(\theta_{0}) > \beta(\theta_{-})$$

where both  $\beta(\theta_+)$  and  $\beta(\theta_-)$  are power but  $\beta(\theta_0)$  is Type I error.

Hence, power can be smaller than the Type I error when  $\theta < \theta_0$ , so the test is biased.

### Uniformly Most Powerful Test (UMP)

**Definition:** Let  $\mathcal{C}$  be a class of tests between  $H_0: \theta \in \Omega$  vs  $H_1: \theta \in \Omega_0^c$ . A test in  $\mathcal{C}$ , with power function  $\beta(\theta)$  is uniformly most powerful (UMP) test in class  $\mathcal{C}$  if  $\beta(\theta) \geq \beta'(\theta)$  for every  $\theta \in \Omega_0^c$  and every  $\beta'(\theta)$ , which is a power function of another test in  $\mathcal{C}$ .

## UMP level $\alpha$ test

Consider C to be the set of all the level  $\alpha$  test. The UMP test in this class is called a UMP level  $\alpha$  test.

UMP level  $\alpha$  test has the smallest type II error probability for any  $\theta \in \Omega_0^c$  in this class.

- A UMP test is "uniform" in the sense that it is most powerful for every  $\theta \in \Omega_0^c$ .
- For simple hypothesis such as  $H_0: \theta = \theta_0$  and  $H_1: \theta = \theta_1$ , UMP level  $\alpha$  test always exists.

## Neyman-Pearson Lemma

**Theorem 8.3.12 - Neyman-Pearson Lemma:** Consider testing  $H_0: \theta = \theta_0$  vs.  $H_1: \theta = \theta_1$  where the pdf or pmf corresponding to  $\theta_i$  is  $f(\mathbf{x}|\theta_i)$ , i = 0, 1, using a test with rejection region R that satisfies

$$\mathbf{x} \in R$$
 if  $f(\mathbf{x}|\theta_1) > kf(\mathbf{x}|\theta_0)$  (8.3.1)  $\mathbf{x} \in R^c$  if  $f(\mathbf{x}|\theta_1) < kf(\mathbf{x}|\theta_0)$ 

for some  $k \geq 0$  and

$$\alpha = \Pr(\mathbf{X} \in R | \theta_0). \tag{8.3.2}$$

Then,

- (Sufficiency) Any test that satisfies 8.3.1 and 8.3.2 is a UMP level  $\alpha$  test
- (Necessity) If there exist a test satisfying 8.3.1 and 8.3.2 with k > 0, then every UMP level  $\alpha$  test is a size  $\alpha$  test (satisfies 8.3.2), and every UMP level  $\alpha$  test satisfies 8.3.1 except perhaps on a set A satisfying  $\Pr(\mathbf{X} \in A | \theta_0) = \Pr(\mathbf{X} \in A | \theta_1) = 0$ .

**Example 5:** Let  $X \sim Binomial(2, \theta)$ , and consider testing  $H_0: \theta = \theta_0 = 1/2$  vs.  $H_1: \theta = \theta_1 = 3/4$ .

Calculating the ratios of the pmfs given,

$$\frac{f(0|\theta_1)}{f(0|\theta_0)} = \frac{1}{4}, \qquad \frac{f(1|\theta_1)}{f(1|\theta_0)} = \frac{3}{4}, \qquad \frac{f(2|\theta_1)}{f(2|\theta_0)} = \frac{9}{4}$$

• Suppose that k < 1/4, then the rejection region  $R = \{0, 1, 2\}$ , and UMP level  $\alpha$  test always rejects  $H_0$ . Therefore

$$\alpha = \Pr(\text{reject } H_0 | \theta = \theta_0 = 1/2) = 1.$$

• Suppose that 1/4 < k < 3/4, then  $R = \{1, 2\}$ , and UMP level  $\alpha$  test rejects  $H_0$  if x = 1 or x = 2.

$$\alpha = \Pr(\text{reject } H_0 | \theta = \frac{1}{2}) = \Pr(x \neq 0 | \theta = 1/2) = \frac{3}{4}$$

• Suppose that 3/4 < k < 9/4, then UMP level  $\alpha$  test rejects  $H_0$  if x = 2

$$\alpha = \Pr(\text{reject}H_0|\theta = 1/2) = \Pr(x = 2|\theta = 1/2) = \frac{1}{4}$$

• If k > 9/4 the UMP level  $\alpha$  test will always not reject  $H_0$ , and  $\alpha = 0$ 

**Example 6 – Normal Distribution:**  $X_i \sim \mathcal{N}(\theta, \sigma^2)$  where  $\sigma^2$  is known. Consider testing  $H_0: \theta = \theta_0$  vs.  $H_1: \theta = \theta_1$  where  $\theta_1 > \theta_0$ .

$$f(\mathbf{x}|\theta) = \prod_{i=1}^{n} \left[ \frac{1}{2\pi\sigma^{2}} \exp\left\{ -\frac{(x_{i} - \theta)^{2}}{2\sigma^{2}} \right\} \right]$$

$$\frac{f(\mathbf{x}|\theta_{1})}{f(\mathbf{x}|\theta_{0})} = \frac{\exp\left\{ -\frac{\sum_{i=1}^{n} (x_{i} - \theta_{1})^{2}}{2\sigma^{2}} \right\}}{\exp\left\{ -\frac{\sum_{i=1}^{n} (x_{i} - \theta_{0})^{2}}{2\sigma^{2}} \right\}}$$

$$= \exp\left[ -\frac{\sum_{i=1}^{n} (x_{i} - \theta_{1})^{2}}{2\sigma^{2}} + \frac{\sum_{i=1}^{n} (x_{i} - \theta_{0})^{2}}{2\sigma^{2}} \right]$$

$$= \exp\left[ \frac{\sum_{i=1}^{n} (x_{i} - \theta_{0})^{2} - \sum_{i=1}^{n} (x_{i} - \theta_{1})^{2}}{2\sigma^{2}} \right]$$

$$= \exp\left[ \frac{n(\theta_{0}^{2} - \theta_{1}^{2}) + 2\sum_{i=1}^{n} x_{i}(\theta_{1} - \theta_{0})}{2\sigma^{2}} \right]$$

UMP level  $\alpha$  test rejects  $H_0$  if

$$\exp\left[\frac{n(\theta_0^2 - \theta_1^2) + 2\sum_{i=1}^n x_i(\theta_1 - \theta_0)}{2\sigma^2}\right] > k$$

$$\iff \frac{n(\theta_0^2 - \theta_1^2) + 2\sum_{i=1}^n x_i(\theta_1 - \theta_0)}{2\sigma^2} > \log k$$

$$\iff \sum_{i=1}^n x_i > k^*$$

$$\alpha = \Pr\left(\sum_{i=1}^n X_i > k^* | \theta_0\right)$$

Under  $H_0$ ,

$$X_i \sim \mathcal{N}(\theta_0, \sigma^2)$$

$$\overline{X} \sim \mathcal{N}(\theta_0, \sigma^2/n)$$

$$\frac{\overline{X} - \theta_0}{\sigma/\sqrt{n}} \sim \mathcal{N}(0, 1)$$

$$\alpha = \Pr\left(\sum_{i=1}^n X_i > k^* | \theta_0\right)$$

$$= \Pr\left(Z > \frac{k^*/n - \theta_0}{\sigma/\sqrt{n}}\right)$$

where  $Z \sim \mathcal{N}(0, 1)$ .

$$\frac{k^*/n - \theta_0}{\sigma/\sqrt{n}} = z_{\alpha}$$

$$k^* = n \left(\theta_0 + z_{\alpha} \frac{\sigma}{\sqrt{n}}\right)$$

Thus, the UMP level  $\alpha$  test rejects  $H_0$  if  $\sum X_i > k^*$ , or equivalently, rejects  $H_0$  if  $\overline{X} > k^*/n = \theta_0 + z_\alpha \sigma/\sqrt{n}$ 

# Neyman-Pearson Lemma on Sufficient Statistics

Corollary 8.3.13: Consider  $H_0: \theta = \theta_0$  vs  $H_1: \theta = \theta_1$ . Suppose  $T(\mathbf{X})$  is a sufficient statistic for  $\theta$  and  $g(t|\theta_i)$  is the pdf or pmf of T. Corresponding  $\theta_i, i \in \{0, 1\}$ . Then any test based on T with rejection region S is a UMP level  $\alpha$  test if it satisfies

$$t \in S$$
 if  $g(t|\theta_1) > k \cdot g(t|\theta_0)$  and  $t \in S^c$  if  $g(t|\theta_1) < k \cdot g(t|\theta_0)$ 

for some k > 0 and  $\alpha = \Pr(T \in S | \theta_0)$ 

**Proof:** The rejection region in the sample space is

$$R = \{\mathbf{x} : T(\mathbf{x}) = t \in S\}$$
$$= \{\mathbf{x} : g(T(\mathbf{x})|\theta_1) > kg(T(\mathbf{x})|\theta_0)\}$$

By Factorization Theorem:

$$f(\mathbf{x}|\theta_i) = h(\mathbf{x})g(T(\mathbf{x})|\theta_i)$$

$$R = \{\mathbf{x} : g(T(\mathbf{x})|\theta_1)h(x) > kg(T(\mathbf{x})|\theta_0)h(x)\}$$

$$= \{\mathbf{x} : f(\mathbf{x}|\theta_1) > kf(\mathbf{x}|\theta_0)\}$$

By Neyman-Pearson Lemma, this test is the UMP level  $\alpha$  test, and

$$\alpha = \Pr(\mathbf{X} \in R) = \Pr(T(\mathbf{X}) \in S | \theta_0)$$

### Revisiting the Example of Normal Distribution

 $X_i \sim \mathcal{N}(\theta, \sigma^2)$  where  $\sigma^2$  is known. Consider testing

$$H_0: \theta = \theta_0 \ vs. \ H_1: \theta = \theta_1, \ where \ \theta_1 > \theta_0.$$

It is known that  $T = \overline{X}$  is a sufficient statistic for  $\theta$ , where  $T \sim \mathcal{N}(\theta, \sigma^2/n)$ .

$$g(t|\theta_{i}) = \frac{1}{\sqrt{2\pi\sigma^{2}/n}} \exp\left\{-\frac{(t-\theta_{i})^{2}}{2\sigma^{2}/n}\right\}$$

$$\frac{g(t|\theta_{1})}{g(t|\theta_{0})} = \frac{\exp\left\{-\frac{(t-\theta_{1})^{2}}{2\sigma^{2}/n}\right\}}{\exp\left\{-\frac{(t-\theta_{0})^{2}}{2\sigma^{2}/n}\right\}}$$

$$= \exp\left\{-\frac{1}{2\sigma^{2}/n}\left[(t-\theta_{1})^{2}-(t-\theta_{0})^{2}\right]\right\}$$

$$= \exp\left\{-\frac{1}{2\sigma^{2}/n}\left[\theta_{1}^{2}-\theta_{0}^{2}-2t(\theta_{1}-\theta_{0})\right]\right\}$$

UMP level  $\alpha$  test rejects  $H_0$  if

$$\exp\left\{-\frac{1}{2\sigma^2/n}\left[\theta_1^2 - \theta_0^2 - 2t(\theta_1 - \theta_0)\right]\right\} > k$$

$$\iff \frac{1}{2\sigma^2/n}\left[-(\theta_1^2 - \theta_0^2) + 2t(\theta_1 - \theta_0)\right] > \log k$$

$$\iff \overline{X} = t > k^*$$

Under  $H_0$ ,  $\overline{X} \sim \mathcal{N}(\theta_0, \sigma^2/n)$ . Now,

$$\Pr(\text{reject } H_0|\theta_0) = \alpha$$

$$\alpha = \Pr(\overline{X} > k^*|\theta_0)$$

$$= \Pr\left(\frac{\overline{X} - \theta_0}{\sigma/\sqrt{n}} > \frac{k^* - \theta_0}{\sigma/\sqrt{n}}\right)$$

$$= \Pr\left(Z > \frac{k^* - \theta_0}{\sigma/\sqrt{n}}\right)$$

$$\frac{k^* - \theta_0}{\sigma/\sqrt{n}} = z_\alpha$$

$$k^* = \theta_0 + z_\alpha \frac{\sigma}{\sqrt{n}}$$

#### Monotone Likelihood Ratio (Karlin-Rubin)

**Definition:** A family of pdfs or pmfs  $\{g(t|\theta) : \theta \in \Omega\}$  for a univariate random variable T with real-valued parameter  $\theta$  have a monotone likelihood ratio if  $\frac{g(t|\theta_2)}{g(t|\theta_1)}$  is an increasing (or non-decreasing) function of t for every  $\theta_2 > \theta_1$  on  $\{t : g(t|\theta_1) > 0 \text{ or } g(t|\theta_2) > 0\}$ .

Note: we may define MLR using decreasing function of t. But all following theorems are stated according to the definition.

#### Examples of Monotone Likelihood Ratio

- Normal, Poisson, Binomial have the MLR Property (Exercise 8.25)
- If T is from an exponential family with the pdf or pmf

$$g(t|\theta) = h(t)c(\theta)\exp[w(\theta) \cdot t]$$

Then T has an MLR if  $w(\theta)$  is a non-decreasing function of  $\theta$ .

**Proof:** Suppose that  $\theta_2 > \theta_1$ .

$$\frac{g(t|\theta_2)}{g(t|\theta_1)} = \frac{h(t)c(\theta_2)\exp[w(\theta_2)t]}{h(t)c(\theta_1)\exp[w(\theta_1)t]}$$
$$= \frac{c(\theta_2)}{c(\theta_1)}\exp[\{w(\theta_2) - w(\theta_1)\}t]$$

If  $w(\theta)$  is a non-decreasing function of  $\theta$ , then

- 1.  $w(\theta_2) w(\theta_1) \ge 0$  and
- 2.  $\exp[\{w(\theta_2) w(\theta_1)\}t]$  is an increasing function of t.

Therefore,  $\frac{g(t|\theta_2)}{g(t|\theta_1)}$  is a non-decreasing function of t, and T has MLR if  $w(\theta)$  is a non-decreasing function of  $\theta$ .

## Karlin-Rubin Theorem

**Theorem 8.3.17:** Suppose  $T(\mathbf{X})$  is a sufficient statistic for  $\theta$  and the family  $\{g(t|\theta): \theta \in \Omega\}$  is an MLR family. Then

- 1. For testing  $H_0: \theta \leq \theta_0$  vs  $H_1: \theta > \theta_0$ , the UMP level  $\alpha$  test is given by rejecting  $H_0$  is and only if  $T > t_0$  where  $\alpha = \Pr(T > t_0 | \theta_0)$ .
- 2. For testing  $H_0: \theta \geq \theta_0$  vs  $H_1: \theta < \theta_0$ , the UMP level  $\alpha$  test is given by rejecting  $H_0$  if and only if  $T < t_0$  where  $\alpha = \Pr(T < t_0 | \theta_0)$ .

**Example 7:** Let  $X_i \sim \mathcal{N}(\theta, \sigma^2)$  where  $\sigma^2$  is known, Find the UMP level  $\alpha$  test for  $H_0: \theta \leq \theta_0$  vs  $H_1: \theta > \theta_0$ .

**Solution:** Here  $T(\mathbf{X}) = \overline{X}$  is a sufficient statistic for  $\theta$ , and  $T \sim \mathcal{N}(\theta, \sigma^2/n)$ . Therefore

$$g(t|\theta) = \frac{1}{\sqrt{2\pi\sigma^2/n}} \exp\left\{-\frac{(t-\theta)^2}{2\sigma^2/n}\right\}$$

$$= \frac{1}{\sqrt{2\pi\sigma^2/n}} \exp\left\{-\frac{t^2+\theta^2-2t\theta}{2\sigma^2/n}\right\}$$

$$= \frac{1}{\sqrt{2\pi\sigma^2/n}} \exp\left\{-\frac{t^2}{2\sigma^2/n}\right\} \exp\left\{-\frac{\theta^2}{2\sigma^2/n}\right\} \exp\left\{\frac{t\theta}{\sigma^2/n}\right\}$$

$$= h(t)c(\theta) \exp[w(\theta)t]$$

where  $w(\theta) = \frac{\theta}{\sigma^2/n}$  is an increasing function in  $\theta$ . Therefore T has an MLR property.

## Finding a UMP level $\alpha$ test

By Karlin-Rubin Theorem, UMP level  $\alpha$  test rejects  $H_0$  iff  $T>t_0$ 

$$\alpha = \Pr(T > t_0 | \theta_0)$$

$$= \Pr\left(\frac{T - \theta_0}{\sigma / \sqrt{n}} > \frac{t_0 - \theta_0}{\sigma / \sqrt{n}} \middle| \theta_0\right)$$

$$= \Pr\left(Z > \frac{t_0 - \theta_0}{\sigma / \sqrt{n}}\right)$$

where  $Z \sim \mathcal{N}(0, 1)$ .

$$\frac{t_0 - \theta_0}{\sigma / \sqrt{n}} = z_{\alpha}$$

$$\Rightarrow t_0 = \theta_0 + \frac{\sigma}{\sqrt{n}} z_{\alpha}$$

UMP level  $\alpha$  test rejects  $H_0$  if  $T = \overline{X} > \theta_0 + \frac{\sigma}{\sqrt{n}} z_{\alpha}$ .

Testing  $H_0: \theta \geq \theta_0$  vs.  $H_1: \theta < \theta_0$ 

UMP level  $\alpha$  test rejects  $H_0$  if  $T < t_0$  where

$$\alpha = \Pr(T < t_0 | \theta_0) = \Pr\left(\frac{T - \theta_0}{\sigma / \sqrt{n}} < \frac{t_0 - \theta_0}{\sigma / \sqrt{n}}\right)$$

$$= \Pr\left(Z < \frac{t_0 - \theta_0}{\sigma / \sqrt{n}}\right)$$

$$1 - \alpha = \Pr\left(Z \ge \frac{t_0 - \theta_0}{\sigma / \sqrt{n}}\right)$$

$$\frac{t_0 - \theta_0}{\sigma / \sqrt{n}} = z_{1-\alpha}$$

$$t_0 = \theta_0 + \frac{\sigma}{\sqrt{n}} z_{1-\alpha} = \theta_0 - \frac{\sigma}{\sqrt{n}} z_{\alpha}$$

Therefore, the test rejects  $H_0$  if  $T < t_0 = \theta_0 - \frac{\sigma}{\sqrt{n}} z_\alpha$ 

Example 8: Normal Example with Known Mean Let  $X_i \sim \mathcal{N}(\mu_0, \sigma^2)$  where  $\sigma^2$  is unknown and  $\mu_0$  is known. Find the UMP level  $\alpha$  test for testing  $H_0: \sigma^2 \leq \sigma_0^2$  vs.  $H_1: \sigma^2 > \sigma_0^2$ . Let  $T = \sum_{i=1}^n (X_i - \mu_0)^2$  is sufficient for  $\sigma^2$ .

To check whether T has MLR property, we need to find  $g(t|\sigma^2)$ .

$$\frac{X_i - \mu_0}{\sigma} \sim \mathcal{N}(0, 1)$$

$$\left(\frac{X_i - \mu_0}{\sigma}\right)^2 \sim \chi_1^2$$

$$Y = T/\sigma^2 = \sum_{i=1}^n \left(\frac{X_i - \mu_0}{\sigma}\right)^2 \sim \chi_n^2$$

$$f_Y(y) = \frac{1}{\Gamma\left(\frac{n}{2}\right) 2^{n/2}} y^{\frac{n}{2} - 1} e^{-\frac{y}{2}}$$

$$f_T(t) = \frac{1}{\Gamma\left(\frac{n}{2}\right) 2^{n/2}} \left(\frac{t}{\sigma^2}\right)^{\frac{n}{2} - 1} e^{-\frac{t}{2\sigma^2}} \left|\frac{dy}{dt}\right|$$

$$= \frac{1}{\Gamma\left(\frac{n}{2}\right) 2^{n/2}} \left(\frac{t}{\sigma^2}\right)^{\frac{n}{2} - 1} e^{-\frac{t}{2\sigma^2}} \frac{1}{\sigma^2}$$

$$= \frac{t^{\frac{n}{2} - 1}}{\Gamma\left(\frac{n}{2}\right) 2^{n/2}} \left(\frac{1}{\sigma^2}\right)^{\frac{n}{2}} e^{-\frac{t}{2\sigma^2}}$$

$$= h(t)c(\sigma^2) \exp[w(\sigma^2)t]$$

where  $w(\sigma^2) = -\frac{1}{2\sigma^2}$  is an increasing function in  $\sigma^2$ . Therefore,  $T = \sum_{i=1}^n (X_i - \mu_0)^2$  has the MLR property.

By Karlin-Rubin Theorem, UMP level  $\alpha$  rejects s  $H_0$  if and only if  $T > t_0$  where  $t_0$  is chosen such that  $\alpha = \Pr(T > t_0 | \sigma_0^2)$ . Note that  $\frac{T}{\sigma^2} \sim \chi_n^2$ . Hence

$$\Pr(T > t_0 | \sigma_0^2) = \Pr\left(\frac{T}{\sigma_0^2} > \frac{t_0}{\sigma_0^2} \middle| \sigma_0^2\right)$$

$$\frac{T}{\sigma_0^2} \sim \chi_n^2$$

$$\Pr\left(\chi_n^2 > \frac{t_0}{\sigma_0^2}\right) = \alpha$$

$$\frac{t_0}{\sigma_0^2} = \chi_{n,\alpha}^2$$

$$t_0 = \sigma_0^2 \chi_{n,\alpha}^2$$

where  $\chi_{n,\alpha}^2$  satisfies  $\int_{\chi_{n,\alpha}^2}^{\infty} f_{\chi_n^2}(x) dx = \alpha$ .

**Example 9:** Let  $X_1, \dots, X_n \sim \mathcal{N}(\theta, \sigma^2)$  where  $\sigma^2$  is known. Consider testing  $H_0: \theta = \theta_0$  versus an alternative hypothesis.

- 1. When the alternative hypothesis is  $H_1: \theta_1 < \theta_0$ , does UMP level  $\alpha$  test exist? If yes, what is it?
- 2. When the alternative hypothesis is  $H_1: \theta_1 > \theta_0$ , does UMP level  $\alpha$  test exist? If yes, what is it?
- 3. When the alternative hypothesis is  $H_1: \theta_1 \neq \theta_0$ , does UMP level  $\alpha$  test exist? If yes, what is it?
- 4. Are the tests above unbiased?

 $H_1: \theta < \theta_0$ 

A level  $\alpha$  test should satisfy  $\Pr(\mathbf{X} \in R | \theta_0) \leq \alpha$ .

As  $\overline{X}$  is sufficient and its distribution has an MLR as shown in the previous example, by Karlin-Rubin Theorem, the rejection region of UMP level  $\alpha$  test is

$$\overline{X} < -\frac{\sigma z_{\alpha}}{\sqrt{n}} + \theta_0$$

 $H_1: \theta > \theta_0$ 

As  $\overline{X}$  is sufficient and its distribution has an MLR as shown in the previous example, by Karlin-Rubin Theorem, the rejection region of UMP level  $\alpha$  test is

$$\overline{X} > \frac{\sigma z_{\alpha}}{\sqrt{n}} + \theta_0$$

 $H_1: \theta \neq \theta_0$ 

- 1. When  $\theta < \theta_0$ ,  $\beta_1(\theta) = \Pr(\mathbf{X} \in R_1) = \Pr\left(\overline{X} < -\frac{\sigma z_{\alpha}}{\sqrt{n}} + \theta_0\right)$  is the largest among level  $\alpha$  tests.
- 2. If UMP level  $\alpha$  test exists, the rejection region must be  $R_1$  by the necessity condition of Neyman-Pearson Lemma.
- 3. When  $\theta > \theta_0$ ,  $\beta_2(\theta) = \Pr(\mathbf{X} \in R_2) = \Pr\left(\overline{X} > \frac{\sigma z_{\alpha}}{\sqrt{n}} + \theta_0\right)$  is the largest among level  $\alpha$  tests.
- 4. Accordingly,  $\beta_1(\theta)$  is not the power function of a UMP level  $\alpha$  test.
- 5. Therefore, UMP level  $\alpha$  test does not exist.

### Are these tests unbiased?

Test based on  $\overline{X} < -\frac{\sigma z_{\alpha}}{\sqrt{n}} + \theta_0$ 

- 1. When  $\theta < \theta_0$ ,  $\beta_1(\theta) > \beta_1(\theta_0)$ .
- 2. When  $\theta > \theta_0$ ,  $\beta_1(\theta) < \beta_1(\theta_0)$ .
- 3. Therefore, the test is not unbiased.

Test based on  $\overline{X} > \frac{\sigma z_{\alpha}}{\sqrt{n}} + \theta_0$ 

- 1. When  $\theta > \theta_0$ ,  $\beta_2(\theta) > \beta_2(\theta_0)$ .
- 2. When  $\theta < \theta_0$ ,  $\beta_2(\theta) < \beta_2(\theta_0)$ .
- 3. Therefore, the test is not unbiased.

# UMPU test

## What is the optimal test for the two-sided test?

Consider a class of unbiased tests. Define a rejection region

$$|\overline{X} - \theta_0| > \frac{\sigma z_{\alpha/2}}{\sqrt{n}}$$

- 1. The test is unbiased.  $\beta_3(\theta) > \beta_3(\theta_0)$  for all  $\theta \neq \theta_0$ .
- 2. The test is indeed the UMP test in the class of unbiased level  $\alpha$  test.
- 3. This test is called a UMPU level  $\alpha$  test.
- 4. Proving that the test is UMPU level  $\alpha$  test is a little more complicated than UMP.

**Example 8:** Let  $X_1, X_2, \ldots, X_n \sim Uniform(0, \theta)$ . Consider testing  $H_0: \theta \leq \theta_0 \ vs. \ H_1: \theta > \theta_0$ .

- (a) Show that the family of  $Uniform(0,\theta)$  has MLR in  $X_{(n)}$ .
- (b) Find a size  $\alpha$  UMP test for the above testing problem.

**Example 9:** Suppose that  $X_1, \dots, X_n$  are i.i.d. observations from Exponential( $\theta$ ), and  $Y_1, \dots, Y_m$  are i.i.d. observations from Exponential( $\mu$ ). Assume that  $X_1, \dots, X_n$  and  $Y_1, \dots, Y_m$  are independent between them.

- (a) Find the LRT statistic of  $H_0: \theta = \mu$  versus  $H_1: \theta \neq \mu$
- (b) Show that the LRT from part (a) can be represented as a function of the following statistic T.

$$T = \frac{\sum_{i=1}^{n} X_i}{\sum_{i=1}^{n} X_i + \sum_{i=1}^{m} Y_i}$$

(Note that it is possible to construct a size  $\alpha$  LRT using the fact that T follows a beta distribution under the null hypothesis.)

```
x=c(seq(0,1,by=0.0001))
z=(x^5)*((1-x)^15)
plot(x,z)
abline(h=.000002)
```

